Finolex Academy Of Management and Technolgy

ACADEMIC CALENDER 2016-17

Electronics and telecommunicn Engineering Department Even Semester (JAN-APRIL) 2016-17

Week Date Activity				
Week	Date	Data	Activity	
01	03/01/2017 To 06/01/2017	<i>Date</i> 01-03-17	Activity Commencement of the Even Semester, Faculty meeting	
02	09/01/2017 To 14/01/2017	14/01/2017	BE project presentation	
03	16/012017 To 20/01/2017		Regular teaching	
04	23/01/2017 To	26/01/2017	Republic Day	
	28/01/2017	28/01/2017	Course enrichment/workshop/add-on course	
OF	30/01/2017	31/01/2017	Faculty meeting	
05	To - 03/02/2017	02-01-17	Display of sessional test-I time table	
	06/02/2017	02-07-17	Display of first defaulter list	
06	То	02-10-17	TECHSPRING by ASENT	
	11/02/2017	02-11-17	Parents meeting of Second year students/TECHSPRING by ASENT	
07	13/02/2017 To 17/02/2017		Regular teaching	
08	20/02/2017 To 25/02/2017	23/02/2017 To 25/02/2017	Internal Assessment-I	
09	27/02/2017 To 03/03/2017	28/02/2017	Faculty meeting	
40	06/03/2017	03-07-17	Display of Second Defaulter's List	
10	To 11/03/2017	9/3/2017- 11/3/2017	UTOPIA	
11	13/03/2017 To 17/03/2017	13/03/2017	HOLIDAY-Dhulivandan	
	20/03/2017	20/03/2017	Display of time table for sessional test-II	
12	To	05/00/0047	Course enrichment/workshop/add-on course	

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Even Semester (JAN-APRIL)2016-17

Week	Date	Activity		
	25/03/2017	Date 25/03/2017	Activity	
			Seminar-Final Year Projects	
13	27/03/2017 To	28/03/2017	HOLIDAY-Gudhi Padava	
	31/03/2017	31/03/2017	Faculty meeting	
14	03/04/2017 To 08/04/2017		Regular teaching	
15	10/04/2017 To	10/04/2017 To 13/04/2017	Internal Assessment-II	
	15/04/2017	14/04/2017	HOLIDAY-Dr.Ambedkar Jayanti	
		15/04/2017	Display of Final Defaulter's List and Term Ends	
16	17/04/2017 To 22/04/2017	17/04/2017 To 22/04/2017	University practical/oral examinations	

Note:

- 1) All the days except the above mentioned are Regular Teaching Days.
- 2) Dates of Sessional Test may subject to change.